


<b>Search Notes</b>  	<b>Application/Control No.</b>  10673368	<b>Applicant(s)/Patent Under Reexamination</b>  CHUNG, HYUN-KWON
	<b>Examiner</b>  Pich, Ponnoreay	<b>Art Unit</b>  2135

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Double patenting search on PALM by inventor name	4/16/08	PP
Updated prior searches on EAST, see notes	4/15/08	PP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner